

Notice of References Cited	Application/Control No. 10/763,353	Applicant(s)/Patent Under Reexamination HOFFMAN ET AL.	
	Examiner JOHANNES P. MONDT	Art Unit 3663	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Young et al., "Growth and characterization of radio frequency magnetron sputter-deposited zinc stannate, Zn ₂ SnO ₄ , thin films", Journal of Applied Physics, Volume 92, Number 1 (July 1, 2002), pages 310-319, especially section V.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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